

EESTI STANDARDI EESSÕNA

NATIONAL FOREWORD

Käesolev Eesti standard EVS-EN 61649:2008 sisaldab Euroopa standardi EN 61649:2008 ingliskeelset teksti.

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Võtmesõnad:

Standardite reprodutseerimis- ja levitamisõigus kuulub Eesti Standardikeskusele

Andmete paljundamine, taastekitamine, kopeerimine, salvestamine elektroonilisse süsteemi või edastamine ükskõik millises vormis või millisel teel on keelatud ilma Eesti Standardikeskuse poolt antud kirjaliku loata.

EUROPEAN STANDARD

EN 61649

NORME EUROPÉENNE EUROPÄISCHE NORM

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English version

Weibull analysis (IEC 61649:2008)

Analyse de Weibull (CEI 61649:2008)

Weibull-Analyse (IEC 61649:2008)

This European Standard was approved by CENELEC on 2008-10-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Cyprus, the Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovenia, Spain, Sweden, Switzerland and the United Kingdom.

CENELEC

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

Foreword

The text of document 56/1269/FDIS, future edition 2 of IEC 61649, prepared by IEC TC 56, Dependability, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61649 on 2008-10-01.

The following dates were fixed:

latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

2009-07-01 (dop)

 latest date by which the national standards conflicting with the EN have to be withdrawn

(dow) 2011-10-01

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 61649:2008 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60300-1	NOTE Harmonized as EN 60300-1:2003 (not modified).
IEC 60300-2	NOTE Harmonized as EN 60300-2:2004 (not modified).
IEC 60300-3-1	NOTE Harmonized as EN 60300-3-1:2004 (not modified).
IEC 60300-3-2	NOTE Harmonized as EN 60300-3-2:2005 (not modified).
IEC 60300-3-4	NOTE Harmonized as EN 60300-3-4:2008 (not modified).
IEC 61703	NOTE Harmonized as EN 61703:2002 (not modified).

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60050-191	1990	International Electrotechnical Vocabulary (IEV) - Chapter 191: Dependability and quality of service	-	-
IEC 60300-3-5	2001	Dependability management - Part 3-5: Application guide - Reliability test conditions and statistical test principles	-	-
IEC 61810-2	- 1)	Electromechanical elementary relays - Part 2: Reliability	EN 61810-2	2005 2)
ISO 2854	1976	Statistical interpretation of data - Techniques of estimation and tests relating to means and variances		-
ISO 3534-1	2006	Statistics - Vocabulary and symbols - Part 1: General statistical terms and terms used in probability		- - - -
1) Undated reference.				
²⁾ Valid edition at date				

¹⁾ Undated reference.

²⁾ Valid edition at date of issue.

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INTRODUCTION

The Weibull distribution is used to model data regardless of whether the failure rate is increasing, decreasing or constant. The Weibull distribution is flexible and adaptable to a wide range of data. The time to failure, cycles to failure, mileage to failure, mechanical stress or similar continuous parameters need to be recorded for all items. A life distribution can be modelled even if not all the items have failed.

Guidance is given on how to perform an analysis using a spreadsheet program. Guidance is ant.
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anduranc. also given on how to analyse different failure modes separately and identify a possible weak population. Using the three-parameter Weibull distribution can give information on time to first failure or minimum endurance in the sample.

WEIBULL ANALYSIS

1 Scope

This International Standard provides methods for analysing data from a Weibull distribution using continuous parameters such as time to failure, cycles to failure, mechanical stress, etc.

This standard is applicable whenever data on strength parameters, e.g. times to failure, cycles, stress, etc. are available for a random sample of items operating under test conditions or in-service, for the purpose of estimating measures of reliability performance of the population from which these items were drawn.

This standard is applicable when the data being analysed are independently, identically distributed. This should either be tested or assumed to be true (see IEC 60300-3-5).

In this standard, numerical methods and graphical methods are described to plot data, to make a goodness-of-fit test, to estimate the parameters of the two- or three-parameter Weibull distribution and to plot confidence limits. Guidance is given on how to interpret the plot in terms of risk as a function of time, failure modes and possible weak population and time to first failure or minimum endurance.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-191:1990, International Electrotechnical Vocabulary – Part 191: Dependability and quality of service

IEC 60300-3-5:2001, Dependability management – Part 3-5: Application guide – Reliability test conditions and statistical test principles

IEC 61810-2, Electromechanical elementary relays - Part 2: Reliability

ISO 2854:1976, Statistical interpretation of data – Techniques of estimations and tests relating to means and variances

ISO 3534-1:2006, Statistics – Vocabulary and symbols – Part 1: General statistical terms and terms in probability

3 Terms, definitions, abbreviations and symbols

For the purposes of this document, the definitions, abbreviations and symbols given in IEC 60050-191 and ISO 3534-1 apply, together with the following.

3.1 Terms and definitions

3.1.1

censoring

terminating a test after either a given duration or a given number of failures

NOTE A test terminated when there are still unfailed items may be called a "censored test", and test time data from such tests may be referred to as "censored data".